



January 2002

# Si6955DQ

## Dual 30V P-Channel PowerTrench<sup>®</sup> MOSFET

### General Description

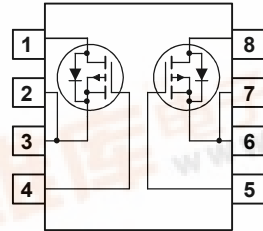
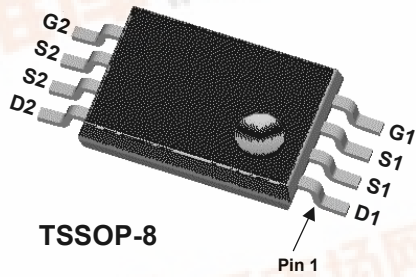
This P-Channel MOSFET is a rugged gate version of Fairchild's Semiconductor's advanced PowerTrench process. It has been optimized for power management applications requiring a wide range of gate drive voltage ratings (4.5V – 20V).

### Applications

- Load switch
- Battery protection
- DC/DC conversion
- Power management

### Features

- -2.5 A, -30 V,  $R_{DS(ON)} = 85\text{ m}\Omega @ V_{GS} = -10\text{ V}$ .  
 $R_{DS(ON)} = 190\text{ m}\Omega @ V_{GS} = -4.5\text{ V}$ .
- Extended  $V_{GSS}$  range ( $\pm 20\text{V}$ ) for battery applications
- Low gate charge
- High performance trench technology for extremely low  $R_{DS(ON)}$
- Low profile TSSOP-8 package



### Absolute Maximum Ratings T<sub>A</sub>=25°C unless otherwise noted

Symbol	Parameter	Ratings	Units
$V_{DSS}$	Drain-Source Voltage	-30	V
$V_{GSS}$	Gate-Source Voltage	$\pm 20$	V
$I_D$	Drain Current – Continuous (Note 1) – Pulsed	-2.5	A
		-20	
$P_D$	Power Dissipation for Single Operation (Note 1a) (Note 1b)	1.0	W
		0.6	
$T_J, T_{STG}$	Operating and Storage Junction Temperature Range	-55 to +150	°C

### Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient (Note 1a) (Note 1b)	100	°C/W
		125	

### Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity
6955	Si6955DQ	13"	12mm	2500 units



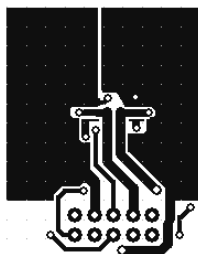
## Electrical Characteristics

$T_A = 25^\circ\text{C}$  unless otherwise noted

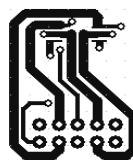
Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
<b>Off Characteristics</b>						
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS} = 0\text{ V}, I_D = -250\ \mu\text{A}$	-30			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = -250\ \mu\text{A}$ , Referenced to $25^\circ\text{C}$		-22		mV/ $^\circ\text{C}$
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = -24\text{ V}, V_{GS} = 0\text{ V}$			-1	$\mu\text{A}$
$I_{GSSF}$	Gate-Body Leakage, Forward	$V_{GS} = -20\text{ V}, V_{DS} = 0\text{ V}$			-100	nA
$I_{GSSR}$	Gate-Body Leakage, Reverse	$V_{GS} = 20\text{ V}, V_{DS} = 0\text{ V}$			100	nA
<b>On Characteristics (Note 2)</b>						
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = -250\ \mu\text{A}$	-1	-1.9	-3	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	$I_D = -250\ \mu\text{A}$ , Referenced to $25^\circ\text{C}$		4		mV/ $^\circ\text{C}$
$R_{DS(on)}$	Static Drain-Source On-Resistance	$V_{GS} = -10\text{ V}, I_D = -2.5\text{ A}$ $V_{GS} = -4.5\text{ V}, I_D = -1.8\text{ A}$ $V_{GS} = -10\text{ V}, I_D = -2.5\text{ A}, T_J = 125^\circ\text{C}$		64 101 96	85 190 128	m $\Omega$
$I_{D(on)}$	On-State Drain Current	$V_{GS} = -10\text{ V}, V_{DS} = -5\text{ V}$	-15			A
$g_{FS}$	Forward Transconductance	$V_{DS} = -10\text{ V}, I_D = -2.5\text{ A}$		6		S
<b>Dynamic Characteristics</b>						
$C_{iss}$	Input Capacitance	$V_{DS} = -10\text{ V}, V_{GS} = 0\text{ V}, f = 1.0\text{ MHz}$		298		pF
$C_{oss}$	Output Capacitance			83		pF
$C_{rss}$	Reverse Transfer Capacitance			39		pF
<b>Switching Characteristics (Note 2)</b>						
$t_{d(on)}$	Turn-On Delay Time	$V_{DD} = -15\text{ V}, I_D = -1\text{ A}, V_{GS} = -10\text{ V}, R_{GEN} = 6\ \Omega$		6	15	ns
$t_r$	Turn-On Rise Time			13	18	ns
$t_{d(off)}$	Turn-Off Delay Time			11	27	ns
$t_f$	Turn-Off Fall Time			6	15	ns
$Q_g$	Total Gate Charge	$V_{DS} = -10\text{ V}, I_D = -2.5\text{ A}, V_{GS} = -10\text{ V}$		6	15	nC
$Q_{gs}$	Gate-Source Charge			1		nC
$Q_{gd}$	Gate-Drain Charge			1.2		nC
<b>Drain-Source Diode Characteristics and Maximum Ratings</b>						
$I_S$	Maximum Continuous Drain-Source Diode Forward Current				-0.83	A
$V_{SD}$	Drain-Source Diode Forward Voltage	$V_{GS} = 0\text{ V}, I_S = -0.83\text{ A}$ (Note 2)		-0.8	-1.2	V

**Notes:**

- $R_{\theta JA}$  is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta CA}$  is determined by the user's board design.



- a)  $100^\circ\text{C/W}$  when mounted on a  $1\text{ in}^2$  pad of 2 oz copper for single operation and  $81^\circ\text{C/W}$  for dual operation.



- b)  $125^\circ\text{C/W}$  when mounted on a minimum pad of 2 oz copper for single operation and  $104^\circ\text{C/W}$  for dual operation.

Scale 1 : 1 on letter size paper

- Pulse Test: Pulse Width <  $300\ \mu\text{s}$ , Duty Cycle < 2.0%

Typical Characteristics

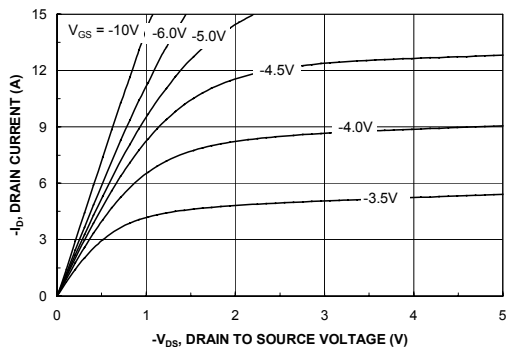


Figure 1. On-Region Characteristics.

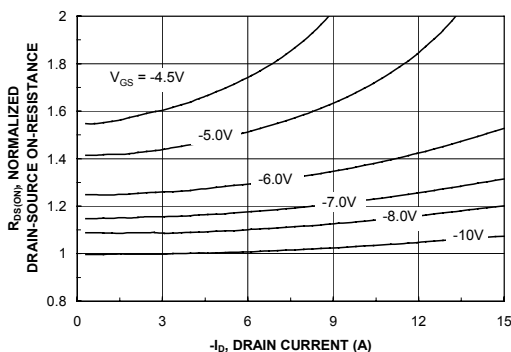


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

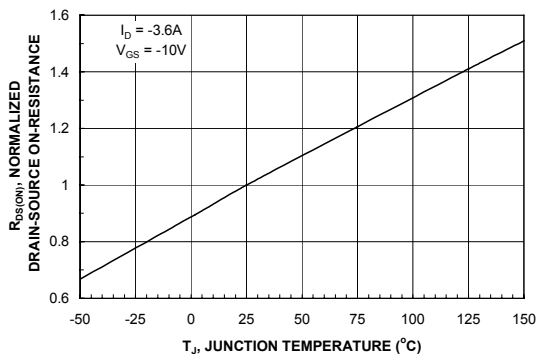


Figure 3. On-Resistance Variation with Temperature.

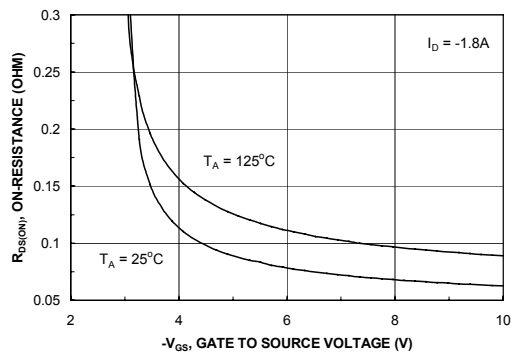


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

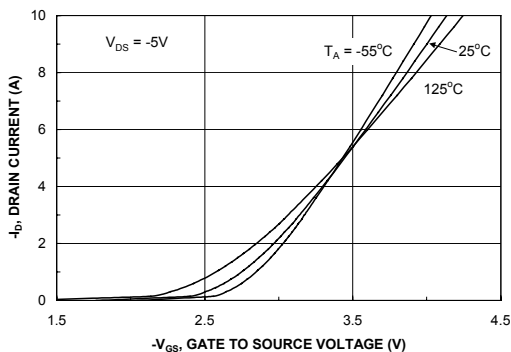


Figure 5. Transfer Characteristics.

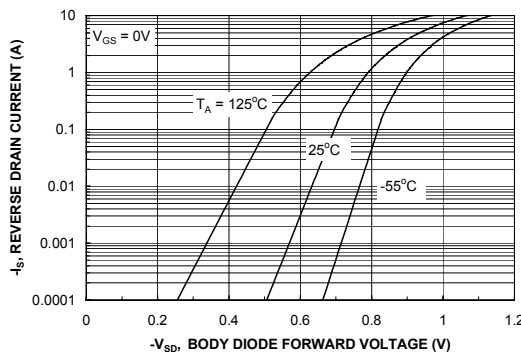
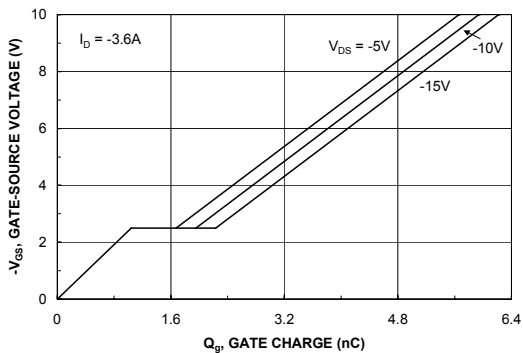
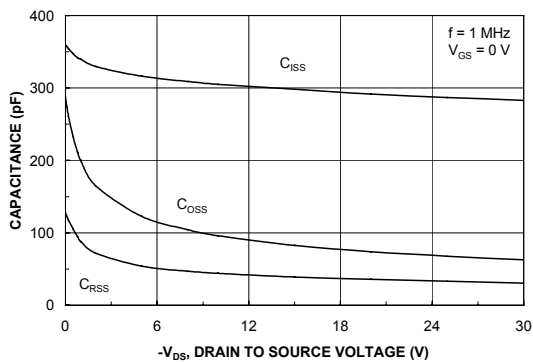


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

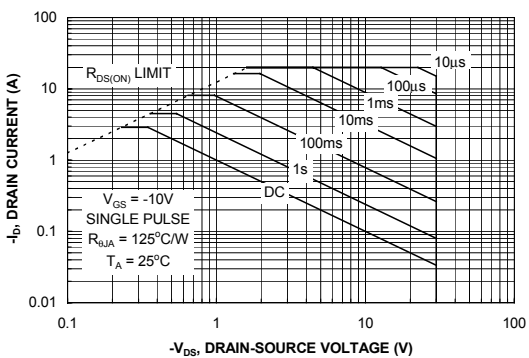
## Typical Characteristics



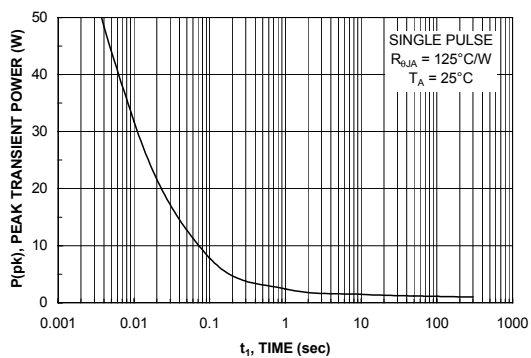
**Figure 7. Gate Charge Characteristics.**



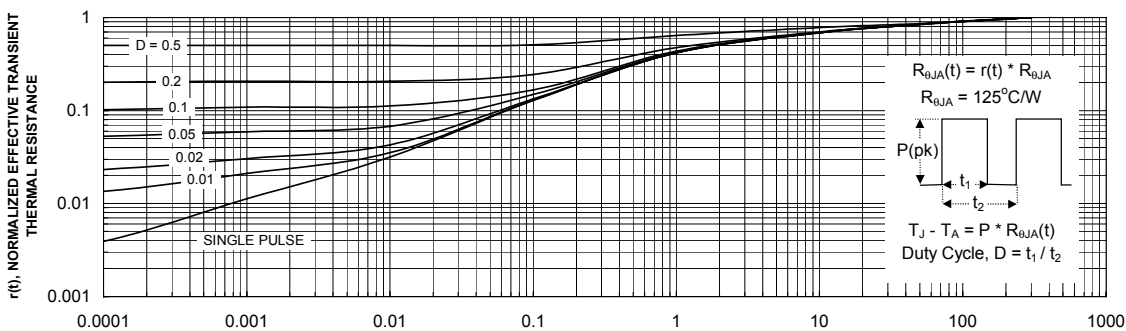
**Figure 8. Capacitance Characteristics.**



**Figure 9. Maximum Safe Operating Area.**



**Figure 10. Single Pulse Maximum Power Dissipation.**



**Figure 11. Transient Thermal Response Curve.**

Thermal characterization performed using the conditions described in Note 1b.  
Transient thermal response will change depending on the circuit board design.

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